Application/Control No. Applicant(s)/Patent Under Reexamination 10/766,808 YAMANAKA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Dung (Michael) T. Nguyen 2828 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * 07-2002 Okazaki et al. 385/27 US-2002/0090172 A1 Α 438/26 11-1982 Fujiwara, Kanji В US-4,360,965 US-С

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